

Page 1 of 60

SAR TEST REPORT

Client Name RM Acquisition LLC.

Address 8770 W. Bryn Mawr Avenue

GPS Device **Product Name**

FCC ID A4C-10013B

10199A-10013B IC ID

Date Jan. 18, 2021

Shenzhen Anboratory Limited probotek Limited

* Approved *

Shenzhen Anbotek Compliance Laboratory Limited





Report No.: 18220WC00157401 Anbotek Page 2 of 60

Contents

1	1. Statement of Compliance				Ann
nbb.		Anbolie	- Hor	- nbotek	0
Z.	2. General Information 2. 1. Client Information	Anbotek	Antoo	hoten	/
	2. 2. Testing Laboratory Information	abotet	Anbole		tek 7
			tek anbol	o	1
	 Description of Equipment Under Test (EUT) 4. Device Category and SAR Limits 			potek Ar	
	2. 4. Device Category and SAR Limits	holey V		Lotek	8
	2. 5. Applied Standard	boten	Anbote	PICE	8
	2. 6. Environment of Test Site 2. 7. Test Configuration	Allek	Anboret	Kanad	8
Ann	2.7. Test Configuration	prob		Annote	8
3.		Pupote.		n anbo	9
	3. 1. Introduction	ICH ANDO	<u>16</u>	10.1	9
	3. 2. SAR Definition		ipotok An	20 ²⁰	9
4.	4. SAR Measurement System	190° - 190		Annoter	
	4.1. E-Field Probe				
	4. 2. Data Acquisition Electronics (DAE)	Anosten	Man	notok	11
	4. 3. Robot	-botek	Pupore	A.0.4	12
	4.4. Measurement Server	P.V	ak	he bubb	13
	4.5. Phantom	en Anbe		ote ^k pal	14
	4. 6. Device Holder	oo ^{tek} p.C	born brin		15
	4. 7. Data Storage and Evaluation	Harak	Ambole. 1	un	16
5.	5. Test Equipment List	An		Anbo	18
6.	6. Tissue Simulating Liquids	Anbe		paboto	19
7.5	7. System Verification Procedures			thoten and the	20
8.	8. Measurement Procedures	india Ha	en Auga		22
	9.1. Spatial Peak SAR Evaluation		soteh Anb	o. b	22
	9.2. Power Reference Measurement			nbote	23
	9.3. Area Scan Procedures	Anbolo	Ann	nbotek	23
	9.4. Zoom Scan Procedures	anboten	Anbo	r spatek	24
	9.5. Volume Scan Procedures	botek	Anbois	P.V.	25
	9. 6. Power Drift Monitoring		sk pobote	Aup	25
9.	No. 19 No. 19 No.	Pur		stek Anb	26
10	10. Antenna Location	otek Ant		potek	29
	10.1 Antenna Location	hotek	Anbou A	ne tek	29
11	11.SAR Test Results Summary	All wotek	Anboten	Anos	30
	12. Simultaneous Transmission Analysis	Anu	obotek	Anbor	31
	13. Measurement Uncertainty	Anbo	k hotek	Anbole	32
	Appendix A. EUT Photos and Test Setup Photos	K Anbote	Altr	tek nb	33
Sc	Appendix B. Plots of SAR System Check	stek sab	oten Anb		34
10	Appendix C. Plots of SAR Test Data	rek.	abotek Al	ipon p	35
	henzhen Anbotek Compliance Laboratory Limited	nbolt	Lotek	Anbotek	
200	ddress: 1/F, Building D, Sogood Science and Technology Park, SanweiCom	munity,	Ambotek	Hotline	PL
Hang	angcheng Street, Bao'an District, Shenzhen, Guangdong, China. el:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotel		Pro	9400-003- ww.anbotek	



Shenzhen Anbotek Compliance Laboratory Limited



Anbotek	安博检测
Product Safety	Anbotek Testing

Page 4 of 60

TEST REPORT

Applicant	: RM Acquisition LLC.	
Manufacturer	: SHEN ZHEN APICAL TECHNOLOGY CO.	, LTD
Product Name	GPS Device	
Model No.	: TND550	
Trade Mark	RAND MENALLY	
Rating(s)	: DC 3.7V from Battery	

Test Standard(s) : FCC 47 CFR Part2.1093 IEEE 1528:2013 ANSI C95.1:1992 RSS 102 Issue 5 IEC 62209-2:2010

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the IEEE 1528-2013, ANSI C95.1:1992, RSS 102 Issue 5 and FCC 47 CFR Part 2.1093 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test Jan. 15, 2021 Jan. 17, 2021

Prepared Bv

Bobby Wang

(Engineer / Bobby Wang)

Snavy

Reviewer

(Supervisor / Snowy Meng)

Zhou

Approved & Authorized Signer

(Manager / Sally Zhang)

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com



Page 5 of 60

Version

Version No.	Date	Description
Anboten 01Anbo	Jan. 18, 2021	Original
Anbole Anbo	tek Anbotek An	Jote Antonek Anbotek Anbo
Anbos An	botek Anboten	And Anbotek Anbotek Anbotek Anbotek A
atek Anbotek	Anbotek Anbo	Anbotek Anbotek Anbotek Anbotek
botek Anbotek	Anboro Ana Ana	Anbotek Anbo hatek Anbotek Anbote
Anbotek Anboter	Anbu sotek Ant	otek Anboto Anto botek Anbotek Anbotek Anbot

Shenzhen Anbotek Compliance Laboratory Limited





1. Statement of Compliance

The maximum results of Specific Absorption Rate (SAR) found during testing are as follows.

<Highest SAR Summary>

Energy Pand	I	Highest Re	eported 1g-	SAR(W/Kg)		SAR Test Limit
Frequency Band		Body			(W/Kg)	
WIFI 2.4G	AND tek	obotek	0.545	P.M. Potek	Anboten	1.6
BT 2.4G	Anbo	Pas botek	0.105	Ano	s abott	1.6
Test Result	Aupor	Pur not	ek anbol	PASS	elt at	otek Anboro

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC 47 CFR part 2 (2.1093), RSS 102 Issue 5 and ANSI C95.1:1992, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528:2013.

Shenzhen Anbotek Compliance Laboratory Limited





2. General Information

2.1. Client Information

LAD" DA		
Applicant	:	RM Acquisition LLC.
Address	:	8770 W. Bryn Mawr Avenue
Manufacturer :		SHEN ZHEN APICAL TECHNOLOGY CO., LTD
Address	:	9/F,B Building, Tinghua Unis Infoport, Langshan RD, North district, Hi-tech Industrial Park, Nanshan, Shenzhen

2.2. Testing Laboratory Information

Test Site:	: Shenzhen Anbotek Compliance Laboratory Limited
Address:	 1/F, Building D, Sogood Science and Technology Park, San community, Hangcheng Street, Bao'an District, Shenzhen, Guangdo China.518102

2. 3. Description of Equipment Under Test (EUT)

Product Name	:	GPS Device	potek Anbotek Anbotek Anbotek Anbotek An		
Model No.	:	TND550	Anbotek Anbotek Anbotek Anbotek		
Trade Mark	:	RAND MENALLY	Annotek Anbotek Anbotek Anbotek Anbotek		
Test Power Supply	:	DC 3.7V from Battery	ak anbotek Anbou tak stotek Anbou		
Hardware version		19308-A64-01C-1			
Software version	:	TND550-20210105-026	tek apolek Anbore Ant		
Product	:	Operation Frequency:	802.11b/ g/ n(HT20): 2412-2462MHz 802.11n(HT40):2422-2462 MHz BT:2402-2480MHz		
Description		Modulation Type:	802.11b: CCK; 802.11g/n: OFDM BT: GFSK, π/4DQPSK, 8DPSK		

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com



Page 7 of 60

Report No.: 18220WC00157401

2.4. Device Category and SAR Limits

Page 8 of 60

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

2.5. Applied Standard

The Specific Absorption Rate (SAR) testing specification, method, and procedure for this device is in accordance with the following standards:

- IEEE 1528:2013
- RSS 102 Issue 5
- IEC 62209-2:2010
- FCC 47 CFR Part 2.1093
- ANSI C95.1:1992
- KDB 248227 D01
- KDB 447498 D01
- KDB 616217 D04
- KDB 865664 D01
 - TCB workshop April 2019; RF Exposure Procedures (Tissue Simulating Liquids)

2.6. Environment of Test Site

	Items	Required	Actual
	Temperature (°C)	18-25 Market Market	22~23
e V	Humidity (%RH)	30-70	55~65

2.7. Test Configuration

The device was controlled by using a base station emulator. Communication between the device and the emulator was established by air link. The distance between the EUT and the antenna of the emulator is larger than 50 cm and the output power radiated from the emulator antenna is at least 30 dB smaller than the output power of EUT. The EUT was set from the emulator to radiate maximum output power during all tests. For WLAN SAR testing, WLAN engineering testing software installed on the EUT can provide continuous transmitting RF signal.

Shenzhen Anbotek Compliance Laboratory Limited





Page 9 of 60

3. Specific Absorption Rate (SAR)

3.1. Introduction

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

3.2. SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ).The equation description is as below:

 $SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dv} \right)$

SAR is expressed in units of Watts per kilogram (W/kg)

SAR measurement can be either related to the temperature elevation in tissue by

$$SAR = C\left(\frac{\delta T}{\delta t}\right)$$

Where: C is the specific head capacity, δT is the temperature rise and δ tisthe exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of the tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

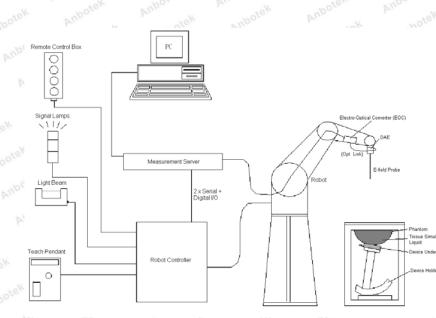
Shenzhen Anbotek Compliance Laboratory Limited





4. SAR Measurement System

Page 10 of 60



DASY System Configurations

The DASY system for performance compliance tests is illustrated above graphically. This system consists of the following items:

- > A standard high precision 6-axis robot with controller, a teach pendant and software
- > A data acquisition electronic (DAE) attached to the robot arm extension
- > A dosimetric probe equipped with an optical surface detector system
- The electro-optical converter (EOC) performs the conversion between optical and electrical signals
- A measurement server performs the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- > A probe alignment unit which improves the accuracy of the probe positioning
- A computer operating Windows XP
- DASY software
- Remove control with teach pendant and additional circuitry for robot safety such as warming lamps, etc.
- The SAM twin phantom
- A device holder
- Tissue simulating liquid
- Dipole for evaluating the proper functioning of the system

components are described in details in the following sub-sections.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

4.1. E-Field Probe

The SAR measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use in liquid with high permittivity. The dosimetric probe has special calibration in liquid at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

E-Field Probe Specification <EX3DV4 Probe>

- No. 14 D.*.	D11 101		1.11
Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)		An
Frequency	10 MHz to 6 GHz; Linearity: ± 0.2 dB	p.ch	1ek
Directivity	± 0.3 dB in HSL (rotation around probe axis)		iboti
	± 0.5 dB in tissue material (rotation normal to probe axis)		Ant
Dynamic Range	10 μW/g to 100 mW/g; Linearity: ± 0.2 dB (noise: typically < 1 μW/g)	ote Y	
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm	Photo of EX3DV4	Anbote

E-Field Probe Calibration

Each probe needs to be calibrated according to a dosimetric assessment procedure with accuracy better than \pm 10%. The spherical isotropy shall be evaluated and within \pm 0.25dB. The sensitivity parameters (NormX, NormY, and NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested. The calibration data can be referred to appendix C of this report.

4. 2. Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com



Page 11 of 60







Photo of DAE

4.3. **Robot**

The SPEAG DASY system uses the high precision robots (DASY5: TX60XL) type from Stäubli SA (France). For the 6-axis controller system, the robot controller version (DASY5: CS8c) from Stäubli is used. The Stäubli robot series have many features that are important for our application:

- High precision (repeatability ±0.035 mm)
 - High reliability (industrial design)
 - Jerk-free straight movements
 - Low ELF interference (the closed metallic construction shields against motor control fields)



Photo of DASY5

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

4.4. Measurement Server

Page 13 of 60

The measurement server is based on a PC/104 CPU board with CPU (DASY5: 400 MHz, Intel Celeron), chip disk (DASY5: 128 MB), RAM (DASY5: 128 MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical detection and digital I/O interface are contained on the DASY I/O board, which is directly connected to the PC/104 bus of the CPU board.

The measurement server performs all the real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operations.



Photo of Server for DASY5

Shenzhen Anbotek Compliance Laboratory Limited



4.5. Phantom

<SAM Twin Phantom>

2 + 0 2 mm ⁻	12	tor.	Anboto
Center ear point: 6 ± 0.2 mm	nbc		
Approx. 25 liters	P1	THE.	CUT.
Length: 1000 mm; Width: 500 mm; Height: adjustable feet	6	T	
Left Hand, Right Hand, Flat	tek		-
Phantom	nbo		
	Approx. 25 litersLength: 1000 mm; Width: 500 mm;Height: adjustable feetLeft Hand, Right Hand, Flat	Center ear point: 6 ± 0.2 mmApprox. 25 litersLength: 1000 mm; Width: 500 mm;Height: adjustable feetLeft Hand, Right Hand, Flat	Center ear point: 6 ± 0.2 mmApprox. 25 litersLength: 1000 mm; Width: 500 mm; Height: adjustable feetLeft Hand, Right Hand, Flat

Photo of SAM Phantom

The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. A white cover is provided to tap the phantom during off-periods to prevent water evaporation and changes in the liquid parameters. On the phantom top, three reference markers are provided to identify the phantom position with respect to the robot.

<ELI4 Phantom>

Shell Thickness	2 ± 0.2 mm (sagging: <1%)	Noter Noter Pr	
Filling Volume	Approx. 30 liters		
Dimensions	Major ellipse axis: 600 mm Minor axis:400 mm		
S.	Ambotek Ambotek Ambotek Ambotek		
	Anbotek Anbotek Anbotek Anbotek Anbo	Photo of ELI4 Phantom	b
	botek Anbor Al tek	aboter And K sotek	

The ELI4 phantom is intended for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI4 is fully compatible with standard and all known tissue simulating liquids.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

4.6. Device Holder

Page 15 of 60

The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5 mm distance, a positioning uncertainty of ± 0.5 mm would produce a SAR uncertainty of $\pm 20\%$. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP).Thus the device needs no repositioning when changing the angles.

The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity ε = 3 and loss tangent δ = 0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.



Device Holder

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

4.7. Data Storage and Evaluation

Page 16 of 60

Data Storage

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files. The post-processing software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of erroneous parameter settings. For example, if a measurement has been performed with an incorrect crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be reevaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type (e.g., [V/m], [A/m], [mW/g]). Some of these units are not available in certain situations or give meaningless results, e.g., a SAR-output in a non-lose media, will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

Data Evaluation

The DASY post-processing software (SEMCAD) automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Normi, a	a io, a i1,
	- Conversion factor	ConvFi	
	- Diode compression point	t dcpi	
Device parameters:	- Frequency	Anbore f	
	- Crest factor	cf	
Media parameters:	- Conductivity	Tootek	
	- Density	γP note ^y	

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multi-meter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com



F

Page 17 of 60

The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with Vi= compensated signal of channel i, (i = x, y, z)

 U_i = input signal of channel i, (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcpi = diode compression point (DASY parameter)

From the compensated input signals, the primary field data for each channel can be evaluated:

-field Probes:
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

H-field Probes: $H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{\epsilon}$

with V_i = compensated signal of channel i,(i = x, y, z)

Norm_i= sensor sensitivity of channel i, (i = x, y, z), $\mu V/(V/m)^2$ for E-field Probes

ConvF= sensitivity enhancement in solution

aij= sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

Ei= electric field strength of channel i in V/m

H_i= magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$\mathbf{E}_{\rm tot} = \sqrt{\mathbf{E}_{\rm x}^2 + \mathbf{E}_{\rm y}^2 + \mathbf{E}_{\rm z}^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{tot}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

with SAR = local specific absorption rate in mW/g

Etot= total field strength in V/m

 σ = conductivity in [mho/m] or [Siemens/m]

 ρ = equivalent tissue density in g/cm³

Note that the density is set to 1, to account for actual head tissue density rather than the density of the tissue simulating liquid.

Shenzhen Anbotek Compliance Laboratory Limited





5. Test Equipment List

Page 18 of 60

Manufacturer	Neme of Equipment	Turne (Mandal	Carial Number	Calibi	ration
Manufacturer	Name of Equipment	Type/Model	Serial Number	Last Cal.	Due Date
SPEAG	2450MHz System Validation Kit	D2450V2	910	Jun 15,2018	Jun 14,2021
SPEAG	Data Acquisition Electronics	DAE4	387	Sep.06,2020	Sep.05,2021
SPEAG	Dosimetric E-Field Probe	EX3DV4	7396	May.06,2020	May.05,2021
Agilent	ENA Series Network Analyzer	E5071C	MY46317418	Nov. 02, 2020	Nov. 01, 2021
SPEAG	DAK	DAK-3.5	1226	NCR	NCR
SPEAG	ELI Phantom	QDOVA004AA	2058	NCR	NCR
AR	Amplifier	ZHL-42W	QA1118004	NCR	NCR
Agilent	Power Meter	N1914A	MY50001102	Nov. 02, 2020	Nov. 01, 2021
Agilent	Power Sensor	N8481H	MY51240001	Nov. 02, 2020	Nov. 01, 2021
R&S	Spectrum Analyzer	N9020A	MY51170037	Nov. 02, 2020	Nov. 01, 2021
Agilent	Signal Generation	N5182A	MY48180656	Nov. 02, 2020	Nov. 01, 2021
Worken	Directional Coupler	0110A05601O- 10	COM5BNW1A2	Nov. 02, 2020	Nov. 01, 2021

Note:

3.

5

The calibration certificate of DASY can be referred to appendix D of this report.

2. The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval.

- The Insertion Loss calibration of Dual Directional Coupler and Attenuator were characterized via the network analyzer and compensated during system check.
- 4. The dielectric probe kit was calibrated via the network analyzer, with the specified procedure (calibrated in pure water) and calibration kit (standard) short circuit, before the dielectric measurement. The specific procedure and calibration kit are provided by Agilent.
 - In system check we need to monitor the level on the power meter, and adjust the power amplifier level to have precise power level to the dipole; the measured SAR will be normalized to 1W input power according to the ratio of 1W to the input power to the dipole. For system check, the calibration of the power amplifier is deemed not critically required for correct measurement; the power meter is critical and we do have calibration for it

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

Page 19 of 60

6. Tissue Simulating Liquids

For the measurement of the field distribution inside the SAM phantom with DASY, the phantom must be filled with around 25 liters of homogeneous body tissue simulating liquid. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm, which is shown in Fig. 6.1. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm, which is shown as followed:



Photo of Liquid Height for Head SAR Ph

Photo of Liquid Height for Body SAR

1.05							a. 1997.		
	Measured	larget l	issue		Measured Tissue				
Tissue Type	Frequenc y (MHz)	٤r	σ	٤r	Dev. (%)	σ	Dev. (%)	Liquid Temp.	Test Data
2450	2450	52.7	1.95	52.12	-1.10	1.93	-1.03	22.2	01/17/2021
2450	2412	52.75	1.91	52.39	-0.68	1.90	-0.52	22.2	01/17/2021
2450	2437	52.71	1.94	52.25	-0.87	1.92	-1.03	22.2	01/17/2021
2450	2462	52.68	1.97	52.03	-1.23	1.94	-1.52	22.2	01/17/2021
	Type 2450 2450 2450	Measured Tissue Measured Type Y 2450 2450 2450 2412 2450 2437	Measured Target T Tissue Frequenc Σεr Yype 2450 2450 52.7 2450 2437 52.71	Measured Target Tissue Tissue Frequenc εr Type y εr σ (MHz) 52.7 1.95 2450 2437 52.71 1.94	Measured Target Tissue Image: Target Tissue Tissue Frequenc εr σ εr Yype 2450 2450 52.7 1.95 52.39 2450 2437 52.71 1.94 52.25	Measured Tissue Type Measured Frequenc y (MHz) Target Tissue Measure σ 2450 2450 52.7 1.95 52.12 -1.10 2450 2412 52.75 1.91 52.39 -0.68 2450 2437 52.71 1.94 52.25 -0.87	Measured Target Tissue Measured Trissue Measured Trissue Type y ϵ_r σ ϵ_r $Dev.$ σ 2450 2450 52.7 1.95 52.39 -0.68 1.90 2450 2437 52.71 1.94 52.25 -0.87 1.92	Measured TissueTarget TissueMeasured TissueTypey (MHz) ϵ_r σ ϵ_r ρ ρ ρ ρ 2450245052.71.9552.12-1.101.93-1.032450241252.751.9152.39-0.681.90-0.522450243752.711.9452.25-0.871.92-1.03	Measured TissueTarget TissueMeasured TissueLiquid $requenc$ y (MHz) ϵ_r σ e_r ρ_r

The following table shows the measuring results for simulating liquid.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

Page 20 of 60

7. System Verification Procedures

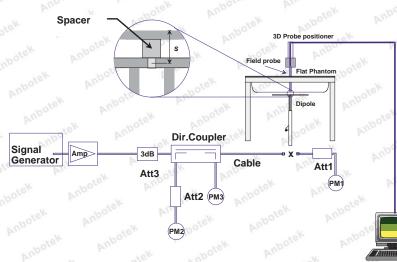
Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

Purpose of System Performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

System Setup

In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:



System Setup for System Evaluation

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com

Report No.: 18220WC00157401

Page 21 of 60



Photo of Dipole Setup

Validation Results

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10%. The table below shows the target SAR and measured SAR after normalized to 1W input power. It indicates that the system performance check can meet the variation criterion and the plots can be referred to Appendix B of this report.

Frequenc y (MHz)	Liquid Type	Power fed onto reference dipole (mW)	Targeted SAR (W/kg)	Measured SAR (W/kg)	Normalized SAR (W/kg)	Deviation (%)	Date
2450	Body	250	51.8	12.74	50.96	-1.62	01/17/2021
190	100.	Pri	101		64 N	NO.	Der.

Target and Measurement SAR after Normalized

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

8. Measurement Procedures

Page 22 of 60

The measurement procedures are as follows:

- (a) Use base station simulator (if applicable) or engineering software to transmit RF power continuously (continuous Tx) in the middle channel.
- (b) Keep EUT to radiate maximum output power or 100% duty factor (if applicable)
- (c) Measure output power through RF cable and power meter.
- (d) Place the EUT in the positions as setup photos demonstrates.
- (e) Set scan area, grid size and other setting on the DASY software.
- (f) Measure SAR transmitting at the middle channel for all applicable exposure positions.
- (g) Identify the exposure position and device configuration resulting the highest SAR
- (h) Measure SAR at the lowest and highest channels at the worst exposure position and device configuration if applicable.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps:

- (a) Power reference measurement
- (b) Area scan
- (c) Zoom scan
- (d) Power drift measurement

9.1. Spatial Peak SAR Evaluation

The procedure for spatial peak SAR evaluation has been implemented according to the test standard. It can be conducted for 1g and 10g, as well as for user-specific masses. The DASY software includes all numerical procedures necessary to evaluate the spatial peak SAR value.

The base for the evaluation is a "cube" measurement. The measured volume must include the 1g and 10g cubes with the highest averaged SAR values. For that purpose, the center of the measured volume is aligned to the interpolated peak SAR value of a previously performed area scan.

The entire evaluation of the spatial peak values is performed within the post-processing engine (SEMCAD). The system always gives the maximum values for the 1g and 10g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- (a) Extraction of the measured data (grid and values) from the Zoom Scan
- (b) Calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- (c) Generation of a high-resolution mesh within the measured volume
- (d) Interpolation of all measured values form the measurement grid to the high-resolution grid
- (e) Extrapolation of the entire 3-D field distribution to the phantom surface over the distance from sensor to surface

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

Page 23 of 60

(f) Calculation of the averaged SAR within masses of 1g and 10g

9.2. Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3. Area Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

		\leq 3 GHz	> 3 GHz
10	Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	$5 \pm 1 \text{ mm}$	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
P	Maximum probe angle from probe axis to phantom surface normal at the measurement location	$30^{\circ} \pm 1^{\circ}$	$20^\circ\pm1^\circ$
0		\leq 2 GHz: \leq 15 mm 2 - 3 GHz: \leq 12 mm	$3 - 4 \text{ GHz} \le 12 \text{ mm}$ $4 - 6 \text{ GHz} \le 10 \text{ mm}$
P	Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area}	When the x or y dimension o measurement plane orientation the measurement resolution r x or y dimension of the test d measurement point on the test	on, is smaller than the above, must be \leq the corresponding levice with at least one

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00157401

9.4. Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label. Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

1974		U PAP	AL DESCRIPTION OF A DES	
	-19		\leq 3 GHz	> 3 GHz
Maximum zoom scan s	spatial reso	lution: Δx _{Zoom} , Δy _{Zoom}	$\leq 2 \text{ GHz:} \leq 8 \text{ mm}$ $2 - 3 \text{ GHz:} \leq 5 \text{ mm}^*$	$3 - 4 \text{ GHz:} \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz:} \le 4 \text{ mm}^*$
	uniform	grid: $\Delta z_{Zoom}(n)$	\leq 5 mm	3 – 4 GHz: ≤ 4 mm 4 – 5 GHz: ≤ 3 mm 5 – 6 GHz: ≤ 2 mm
Maximum zoom scan spatial resolution, normal to phantom surface	graded	$\Delta z_{Zoom}(1)$: between 1 st two points closest to phantom surface	\leq 4 mm	3 – 4 GHz: ≤ 3 mm 4 – 5 GHz: ≤ 2.5 mm 5 – 6 GHz: ≤ 2 mm
	grid		$\leq 1.5 \cdot \Delta z_{Zoom}(n-1)$	
Minimum zoom scan volume	x, y, z	1	≥ 30 mm	3 – 4 GHz: ≥ 28 mm 4 – 5 GHz: ≥ 25 mm 5 – 6 GHz: ≥ 22 mm

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

When zoom scan is required and the <u>reported</u> SAR from the area scan based 1-g SAR estimation procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com



Page 24 of 60

Report No.: 18220WC00157401

9.5. Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregate SAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6. Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drift more than 5%, the SAR will be retested.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com



Page 25 of 60



9. Conducted Power

Mode	Channel	Frequency (MHz)	Conducted Power (dBm)	Tune-up(dBm)	
	1 P. 1	2412	11.04 Jek	12.0 And	
802.11b	abotek 6 Anbor	2437	11.38	12.0 Mo	
	hote11 Ant	2462	11.40	12.0	
	pr 1 _{ok}	2412	10.27	11.0	
802.11g	6	2437	10.56	11.0	
-	× 11,0101	2462	10.51	11.0	
	P1 Lot	2412	10.37	11.0	
802.11n(20MHz)	otek 6 nbor	2437	10.67	tek 11.0 mbote	
	11 note	2462	10.52	11.0	
	mbote 3 Ame	2422	10.77	11.0 M	
802.11n(40MHz)	abotek6 Anb	2437	10.46	11.0 Anto	
	9%	2452	10.51	11.0	

<WIFI 2.4GHz Conducted Power>

Note:

1. Per KDB 447498 D01, the 1-g SAR test exclusion thresholds for 100 MHz to 6 GHz at *test separation distances* ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance,

mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

- 2. Base on the result of note1, RF exposure evaluation of 802.11 b mode is required.
- 3. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion.
- 4. Per KDB 248227 D01, In the 2.4 GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 2.4 GHz OFDM conditions:
 - 1) When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.
 - 2) When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is \leq 1.2 W/kg.

Mode	Channel	Frequency (MHz)	Conducted Average Power (dBm)	Tune-up(dBm)
GFSK	00	2402	-1.94 Photo	-1.00

<Bluetooth Conducted Power>

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com

Hotline 400-003-0500 www.anbotek.com

Report No.: 18220WC00157401

Report No.: 1822	00000157401	Very Martin	Ant	age 27 of 60
	39	2441	-1.24 Photos	-1.00
	78	2480	-1.05	-1.00
	00	2402	0.84	1.00
π/4DQPSK	39	2441	1.16	2.00
	78	2480	2.31 Let	3.00
	abotek 00 Antoo	2402	2.59	4.00
8DPSK	39	2441	3.02	4.00
	78	2480	3.45	4.00
- RAG 7			D.V.	124

For FCC ID:

Per KDB 447498 D01v05r02, the 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}]$

 \leq 3.0 for 1-g SAR and \leq 7.5 for 10-g extremity SAR

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

Band/Mode	F(GHz)	Position	SAR test exclusion	RF output power		SAR test exclusion
Dunu/Wout	(GIIZ)	i ostiton	threshold (mW)	dBm	mW	CACIUSION
Bluetooth	2.45	Body	spotek 9.6 pribo	4.00	2.51	Yes

Per KDB 447498 D01, when the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

P	Desition Anbo	f (GHz)	Distance Upper limit of power *				
	Position		(mm)	dBm	mW	(W/kg)	
62	Body	2.480	nbole 5 And	4.00	2.51	0.105	

Estimated SAR for Bluetooth

- Maximum possible output power declared by manufacturer

When standalone SAR test exclusion applies to an antenna that transmits simultaneously with other antennas, the standalone SAR must be estimated according to following to determine simultaneous transmission SAR test exclusion:

(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)]·[$\sqrt{f(GHz)/x}$] W/kg for test separation distances ≤ 50 mm;

Where x = 7.5 for 1-g SAR.

When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion

For IC ID:

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com

Hotline 400-003-0500 www.anbotek.com

Report No.: 18220WC00157401

Page 28 of 60

According to section 2.5.1 (Exemption from Routine Evaluation Limits – SAR Evaluation) of RSS-102 Issue 5. SAR evaluation is required if the separation distance between the user and/or bystander and the antenna and/or radiating element of the device is less than or equal to 20 cm, except when the device operates at or below the applicable output power level (adjusted for tune-up tolerance) for the specified separation distance defined in Table 1.

Frequency	Exemption Limits (mW)								
(MHz)	At separation distance of ≤5 mm	At separation distance of 10 mm	At separation distance of 15 mm	At separation distance of 20 mm	At separation distance of 25 mm				
≤300	71 mW	101 mW	132 mW	162 mW	193 mW				
450	52 mW	70 mW	88 mW	106 mW	123 mW				
835	17 mW	30 mW	42 mW	55 mW	67 mW				
1900	$7 \mathrm{mW}$	10 mW	18 mW	34 mW	60 mW				
2450	4 mW	7 mW	15 mW	30 mW	52 mW				
3500	2 mW	6 mW	16 mW	32 mW	55 mW				
5800	1 mW	6 mW	15 mW	27 mW	41 mW				

Table 1: SAR evaluation – Exemption limits for routine evaluation based on frequency and separation distance^{4,5}

Frequency		Exe	mption Limits (n	nW)	
(MHz)	At separation distance of 30 mm	At separation distance of 35 mm	At separation distance of 40 mm	At separation distance of 45 mm	At separation distance of ≥50 mm
≤300	223 mW	254 mW	284 mW	315 mW	345 mW
450	141 mW	159 mW	177 mW	195 mW	213 mW
835	80 mW	92 mW	105 mW	117 mW	130 mW
1900	99 mW	153 mW	225 mW	316 mW	431 mW
2450	83 mW	123 mW	173 mW	235 mW	309 mW
3500	86 mW	124 mW	170 mW	225 mW	290 mW
5800	56 mW	71 mW	85 mW	97 mW	106 mW

The Gain of the ant is 0dBi

	S	Standalone	SAR test	exclusio	on consid	derations		
Modulation	Frequency (MHz)	Configuration	Maximum Average Power (dBm)	Maximum EIRP (dBm)	Maximum EIRP (mW)	Separation Distance (mm)	SAR Exclusion Thresholds (mW)	Standalone SAR Exclusion
WIFI(802.11b)	2462	Body*	12.0	12.0	15.85	stek 5	pote ^k 4 A	Yes
BT(GFSK)	2480	Body*	4.00	4.00	2.51	obote 5	Anbotek	Anbols No

Shenzhen Anbotek Compliance Laboratory Limited





10. Antenna Location

10.1 Antenna Location



EUT Bottom Edge

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com

Page 29 of 60



Page 30 of 60

11. SAR Test Results Summary

General Note:

- 1. Per KDB 447498 D01v05r01, the reported SAR is the measured SAR value adjusted for maximum tune-up tolerance.
 - Scaling Factor = tune-up limit power (mW) / EUT RF power (mW), where tune-up limit is the maximum rated power among all production units.
 - Reported SAR(W/kg)= Measured SAR(W/kg)* Scaling Factor
- 2. Per KDB 447498 D01v05r01, for each exposure position, if the highest output channel reported SAR≤0.8W/kg, other channels SAR testing are not necessary

Plot No.	Band	Mode	Test Position	Gap (cm)	Ch.	Frea.	Power	Tune- Up Limit (dBm)	Scaling Factor	SAR ₁₀	Reported SAR _{1g} (W/kg)
010	WIFI 2.4GHz	802.11b	Front	0	11	2462	11.40	12.0	1.148	0.237	0.272
#1	WIFI 2.4GHz	802.11b	Rear	0	11	2462	11.40	12.0	1.148	0.475	0.545
ant	WIFI 2.4GHz	802.11b	Left Side	0.00	11	2462	11.40	12.0	1.148	<0.1	<0.1
12	WIFI 2.4GHz	802.11b	Right Side	0	11	2462	11.40	12.0	1.148	0.113	0.130
4	WIFI 2.4GHz	802.11b	Top Side	0	11	2462	11.40	12.0	1.148	0.127	0.146
	WIFI 2.4GHz	802.11b	Bottom Side	0	11	2462	11.40	12.0	1.148	<0.1	<0.1

<WIFI 2.4GHz>

Note:

Appendix C. Plots of SAR Test Data

Shenzhen Anbotek Compliance Laboratory Limited





Page 31 of 60

12. Simultaneous Transmission Analysis

WIFI 2.4GHz and Bluetooth share the same antenna, and can not transmit simultaneously.

Shenzhen Anbotek Compliance Laboratory Limited





Page 32 of 60

13. Measurement Uncertainty

Per KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz, when the highest measured 1-g SAR within a frequency band is< 1.5 W/Kg, the extensive SAR measurement uncertainty analysis described in IEC 62209-2:2010 is not required in SAR reports submitted for equipment approval.

Shenzhen Anbotek Compliance Laboratory Limited





Page 33 of 60

Appendix A. EUT Photos and Test Setup Photos

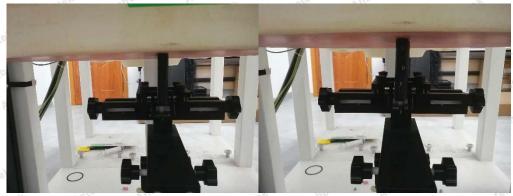


Body Front(0mm)

Body Back(0mm)



Top (0mm)



Left(0mm)

Right(0mm)

Shenzhen Anbotek Compliance Laboratory Limited





Page 34 of

Appendix B. Plots of SAR System Check

Date: 01/17/2021

2450MHz Head System Check

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: 910 Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2450 MHz; $\sigma = 1.93 \text{ S/m}$; $\epsilon r = 52.12$; $\rho = 1000 \text{ kg/m}$ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: 5/6/2020;

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn387; Calibrated: 9/6/2020

Phantom: ELI4; Type: QDOVA001BB; Serial: TP:2062

Measurement SW: DASY52, Version 52.8 (1); SEMCAD X Version 14.6.5 (6469)

Area Scan (61x91x1):Measurement grid: dx=10.00 mm, dy=10.00 mm

Maximum value of SAR (interpolated) = 19.225 mW/g

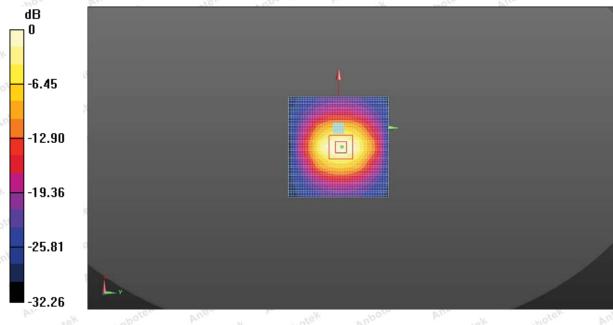
Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 84.153 V/m; Power Drift = 0.05dB

Peak SAR (extrapolated) = 26.125 W/kg

SAR(1 g) = 12.74 mW/g; SAR(10 g) = 5.69 mW/g

Maximum value of SAR (measured) = 19.18mW/g



Shenzhen Anbotek Compliance Laboratory Limited





Page 35 of 60

Appendix C. Plots of SAR Test Data

#1^{°°}

Date: 01/17/2021

WIFI 2.4G_802.11b_ Rear _Ch11

Communication System: UID 0, Generic WIFI (0); Frequency: 2462 MHz;Duty Cycle: 1:1 Medium parameters used: f = 2462 MHz; σ = 1.94 S/m; ϵ_r = 52.03; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: 5/6/2020; Sensor-Surface: 3mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: 9/6/2020 Phantom: ELI4; Type: QDOVA001BB; Serial: TP:2062 Measurement SW: DASY52, Version 52.8 (1); SEMCAD X Version 14.6.5 (6469)

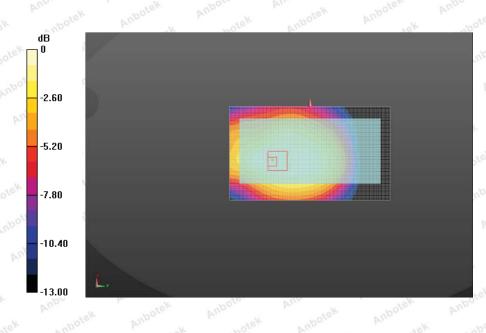
Rear/CH 11/Area Scan (51x101x1): Interpolated grid: dx=1.200 mm, dy=1.200 mm Maximum value of SAR (interpolated) = 0.525 W/kg

Rear/CH 11/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 5.21 V/m; Power Drift = -0.05 dB

Peak SAR (extrapolated) = 0.703 W/kg

SAR(1 g) = 0.475 W/kg; SAR(10 g) = 0.296 W/kg Maximum value of SAR (measured) = 0.523 W/kg



Shenzhen Anbotek Compliance Laboratory Limited





Page 36 of 60

Appendix D. DASY System Calibration Certificate

	In Collaborati	ion with	RETI
TT	Lsp	e a g lac MRA	NAS 校准
Add: No 51 Xuesuar	Road Haidian Distric	t, Beijing, 100191, China	CALIBRATI CNAS L05
Tel: +86-10-6230463 E-mail: cttližchinattl	3-2218 Fax: +86	+10-62304633-2209 ww.chinattl.cn	
	otek (Auden)		68716
19918-1	RTIFICATE		
Object	EX3DV4	- SN:7396	
Calibration Procedure(s)	FF-Z11-0	07.03	
		on Procedures for Dosimetric E-field Probes	
Calibration date:	May06.2	2020	
Contraction of the second	Mayoo,	EVEV	
bages and are part of the cer		e closed laboratory facility: environment t	emperature(22+3) T and
numidity<70%.			
umidity<70%. Calibration Equipment used	(M&TE critical for		Scheduled Calibration
Calibration Equipment used Primary Standards Power Meter NRP2	(M&TE critical for ID # (101919	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447)	Scheduled Calibration Jun-20
umidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2	(M&TE critical for ID # (101919 101547	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447)	Scheduled Calibration Jun-20 Jun-20
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91	(M&TE critical for ID # (101919	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447)	Scheduled Calibration Jun-20 Jun-20 Jun-20
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91	(M&TE critical for ID # (101919 101547	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447)	Scheduled Calibration Jun-20 Jun-20
uumidity<70%. Calibration Equipment used Primary Standards	(M&TE critical for ID # (101919 101547 101548	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL,No.J19X01547)	Scheduled Calibration Jun-20 Jun-20 Jun-20
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Power sensor NRP-291 Reference10dBAttenuator	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL,No.J19X01547)	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548)	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19 (SPEAG,No.EX3-7433_Sep18)	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4	(M&TE critical for ID # 0 101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19(SPEAG, No.EX3-7433_Sep18) 13-Dec-19(SPEAG, No.DAE4-549_Dec18)	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20 Dec -20
aumidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID #	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19 (SPEAG, No.EX3-7433_Sep18) 13-Dec-19 (SPEAG, No.DAE4-549_Dec18) Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20 Dec -20 Scheduled Calibration
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052605	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19 (SPEAG, No.EX3-7433_Sep18) 13-Dec-19 (SPEAG, No.DAE4-549_Dec18) Cal Date(Calibrated by, Certificate No.) 27-Jun-19 (CTTL, No.J18X04776)	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20 Dec -20 Scheduled Calibration Jun-20
aumidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052605 MY46110673	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19(SPEAG, No.DAE4-549_Dec18) 13-Dec-19(SPEAG, No.DAE4-549_Dec18) Cal Date(Calibrated by, Certificate No.) 27-Jun-19 (CTTL, No.J18X04776) 13-Jan-20 (CTTL, No.J19X00285)	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20 Dec -20 Scheduled Calibration Jun-20 Jan -21
Aumidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Power sensor NRP-291 Reference10dBAttenuator Reference20dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C Calibrated by:	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052605 MY46110673 Name	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19(SPEAG, No.DAE4-549_Dec18) 13-Dec-19(SPEAG, No.DAE4-549_Dec18) Cal Date(Calibrated by, Certificate No.) 27-Jun-19 (CTTL, No.J18X04776) 13-Jan-20 (CTTL, No.J19X00285) Function	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20 Dec -20 Scheduled Calibration Jun-20 Jan -21
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052605 MY46110673 Name Yu Zongying	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19(SPEAG, No.DAE4-549_Dec18) 13-Dec-19(SPEAG, No.DAE4-549_Dec18) Cal Date(Calibrated by, Certificate No.) 27-Jun-19 (CTTL, No.J18X04776) 13-Jan-20 (CTTL, No.J19X00285) Function SAR Test Engineer	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20 Dec -20 Scheduled Calibration Jun-20 Jan -21
aumidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Power sensor NRP-291 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C Calibrated by: Reviewed by:	(M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052605 MY46110673 Name Yu Zongying Lin Hao	calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 20-Jun-19 (CTTL, No.J18X07447) 13-Mar-20(CTTL, No.J19X01547) 13-Mar-20(CTTL, No.J19X01548) 26-Sep-19(SPEAG, No.DAE4-549_Dec18) 13-Dec-19(SPEAG, No.DAE4-549_Dec18) Cal Date(Calibrated by, Certificate No.) 27-Jun-19 (CTTL, No.J18X04776) 13-Jan-20 (CTTL, No.J18X04776) 13-Jan-20 (CTTL, No.J19X00285) Function SAR Test Engineer SAR Test Engineer	Scheduled Calibration Jun-20 Jun-20 Jun-20 Mar-21 Mar-21 Sep-20 Dec -20 Scheduled Calibration Jun-20 Jan -21 Signature

Certificate No: Z20-68716

Page 1 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com

Anbotek Product Safety

Report No.: 18220WC00157401



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl/ij/chinattl.com
 <u>Http://www.chinattl.cn</u>

Glossary:

Olossaly.	
TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization 0	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i θ=0 is normal to probe axis.

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013. "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(I)x,y,z = NORMx,y,z* frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax,y,z; Bx,y,z; Cx,y,z; VRx,y,z:A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat
 phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the
 probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: Z20-68716

Page 2 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com

Page 37 of 60





Add: No.51 Xueyunn Road, I Tel: +86-10-62304633-2218 E-mail: ettl@chinatil.com

cyunn Road, Haidian District, Beijing, 100191, China 804633-2218 Fax: +86-10-62304633-2209 inattl.com <u>Http://www.chinattl.cn</u>

Probe EX3DV4

SN: 7396

Calibrated: May 06, 2020

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: Z20-68716

Page 3 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com



Page 38 of 60

botek

Product Safety





 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: ettl@chinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Basic Calibration Parameters

Anbotek Testing

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(µV/(V/m)2)^	0.54	0.53	0.50	±10.0%
DCP(mV) ^B	97.8	104.5	102.5	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB⊲µV	c	D dB	VR mV	Unc ^E (k=2)
0	CW	x	0.0	0.0	1.0	0.00	199.9	±2.4%
	100000	Y	0.0	0.0	1.0		203.3	
		Z	0.0	0.0	1.0		195.0	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5 and Page 6).
^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: Z20-68716

Page 4 of 11

Shenzhen Anbotek Compliance Laboratory Limited



Anbotek Testing

botek

Product Safety

Page 40 of 60



Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191. China Tel: +86-10-62304633-2218 Fax: +86-10-62304633-2209 E-mail: ettl@chinattl.com <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	41.9	0.89	9.82	9.82	9.82	0.30	0.85	±12.1%
835	41.5	0.90	9.71	9.71	9.71	0.15	1.36	±12.1%
900	41.5	0.97	9.87	9.87	9.87	0.16	1.37	±12.1%
1750	40.1	1.37	8.61	8.61	8.61	0.25	1.04	±12.1%
1900	40.0	1.40	8.13	8.13	8.13	0.24	1.01	±12.1%
2100	39.8	1.49	8.14	8.14	8.14	0.24	1.04	±12.1%
2300	39.5	1.67	7.85	7.85	7.85	0.40	0.75	±12.1%
2450	39.2	1.80	7.57	7.57	7.57	0.50	0.75	±12.1%
2600	39.0	1.96	7.38	7.38	7.38	0.64	0.68	±12.1%
5250	35.9	4.71	5.33	5.33	5.33	0.45	1.30	±13.3%
5600	35.5	5.07	4.89	4.89	4.89	0.45	1.35	±13.3%
5750	35.4	5.22	4.92	4.92	4.92	0.45	1.45	±13.3%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.
^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

Certificate No: Z20-68716

Page 5 of 11

Shenzhen Anbotek Compliance Laboratory Limited



botek

Product Safety

Page 41 of 60



品

Anbotek Testing

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2218 Fax: +86-10-62304633-2209 E-mail: ettl@chinattl.com <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	55.5	0.96	10.09	10.09	10.09	0.30	0.90	±12.1%
835	55.2	0.97	9.88	9.88	9.88	0.19	1.32	±12.1%
900	55.0	1.05	9.82	9.82	9.82	0.23	1.15	±12.1%
1750	53.4	1.49	8.24	8.24	8.24	0.24	1.06	±12.1%
1900	53.3	1.52	7.97	7.97	7.97	0.19	1.24	±12.1%
2100	53.2	1.62	8.18	8.18	8.18	0.19	1.39	±12.1%
2300	52.9	1.81	7.88	7.88	7.88	0.55	0.80	±12.1%
2450	52.7	1.95	7.53	7.53	7.53	0.46	0.89	±12.1%
2600	52.5	2.16	7.38	7.38	7.38	0.52	0.80	±12.1%
5250	48.9	5.36	4.93	4.93	4.93	0.45	1.80	±13.3%
5600	48.5	5.77	4.19	4.19	4.19	0.48	1.90	±13.3%
5750	48.3	5.94	4.52	4.52	4.52	0.48	1.95	±13.3%

^C Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters. ^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

Certificate No: Z20-68716

Page 6 of 11

Shenzhen Anbotek Compliance Laboratory Limited





Page 42 of 60

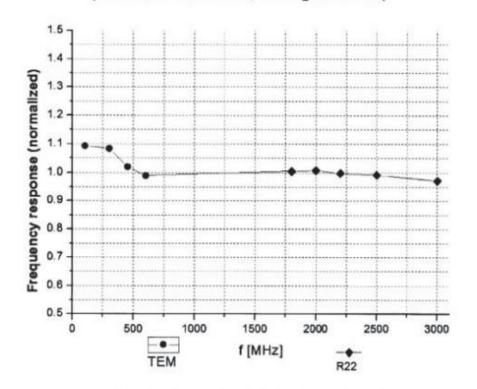


 Add: No.51 Xueyuan Road, Haidian District. Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ±7.4% (k=2)

Certificate No: Z20-68716

Page 7 of 11

Shenzhen Anbotek Compliance Laboratory Limited



Anbotek Product Safety Report No.: 18220WC00157401

Page 43 of 60

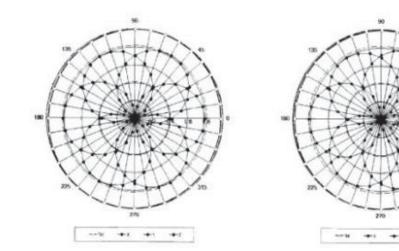


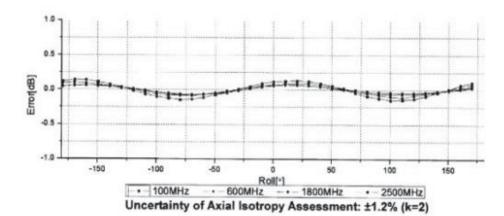
Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2218 Fax: +86-10-62304633-2209 E-mail: cttl@chinattl.com <u>Http://www.chinattl.cn</u>

Receiving Pattern (Φ), θ=0°

f=600 MHz, TEM

f=1800 MHz, R22





Certificate No: Z20-68716

Page 8 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com



1alek

Anbotek **Product Safety**

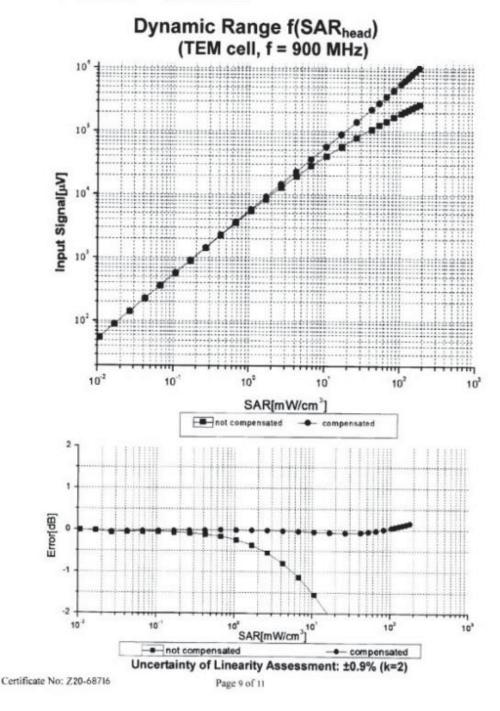




E-mail: ettl@chinattl.com

安博检测 Anbotek Testing

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2218 Fax: +86-10-62304633-2209 Http://www.chinattl.cn



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com

Hotline 400-003-0500 www.anbotek.com

Anbotek Product Safety 安博检测

Anbotek Testing



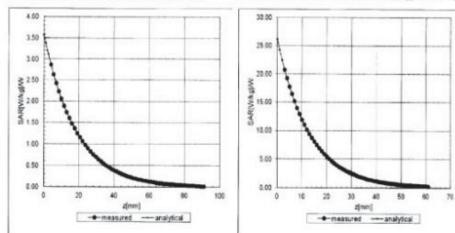


Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2218 Fax: +86-10-62304633-2209 E-mail: ettl@chinatil.com <u>Http://www.chinatil.co</u>

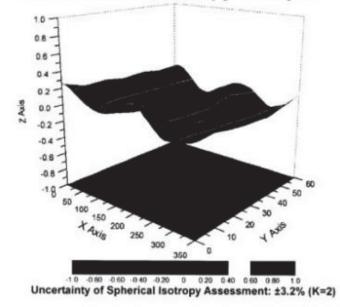
Conversion Factor Assessment

f=900 MHz, WGLS R9(H_convF)

f=1750 MHz, WGLS R22(H_convF)



Deviation from Isotropy in Liquid



Certificate No: Z20-68716

Page 10 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com



ootek

Product Safety

Page 46 of 60



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: ettl/@chinattl.com
 Http://www.chinattl.com

DASY/EASY - Parameters of Probe: EX3DV4 - SN: 7396

Other Probe Parameters

Anbotek Testing

Sensor Arrangement	Triangular
Connector Angle (°)	156.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm

Certificate No: Z20-68716

Page 11 of 11

Shenzhen Anbotek Compliance Laboratory Limited





Page 47 of 60

Schmid & Partner Engineering AG

speag

Zeughausstrasse 43, 8004 Zurich, Switzerland Phone +41 44 245 9700, Fax +41 44 245 9779 info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the Estop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Schmid & Partner Engineering

TN_BR040315AD DAE4.doc

11.12.2009

Sł

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com



Page 48 of 60

	sstrasse 43, 8004 Zuric		"Mulululu" "Min.ch 55"	S Swiss Calibration Service
The Swis		ation Service (SAS) e is one of the signatories ecognition of calibration of	to the EA	tion No.: SCS 0108
Client	Anbotek (Aude			No: DAE4-387_Sep10
CAL	IBRATION C	ERTIFICATE		
Object		DAE4 - SD 000 D	04 BM - SN: 387	
Calibratio	on procedure(s)	QA CAL-06.v29 Calibration procee	dure for the data acquisition el	lectronics (DAE)
Calibratio	on date:	September 06, 20	20	
The mea	surements and the unce	rtainties with confidence pro	nal standards, which realize the physical obability are given on the following pages r facility: environment temperature (22 ± 3	and are part of the certificate.
The mea All calibra	surements and the unce ations have been conduc	rtainties with confidence pro- ted in the closed laboratory rE critical for calibration)	nal standards, which realize the physical obability are given on the following pages r facility: environment temperature (22 ± 3	and are part of the certificate.
The mea All calibra Calibratic Primary S	surements and the unce ations have been conduc on Equipment used (M&T Standards	rtainties with confidence pro- sted in the closed laboratory rE critical for calibration)	obability are given on the following pages r facility: environment temperature (22 ± 3 Cal Date (Certificate No.)	and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration
The mea All calibra Calibratic Primary S	surements and the unce ations have been conduc on Equipment used (M&1	rtainties with confidence pro- ted in the closed laboratory rE critical for calibration)	obability are given on the following pages facility: environment temperature (22 \pm ;	and are part of the certificate. 3)°C and humidity < 70%.
The mea All calibra Calibratio Primary S Keithley I Seconda	surements and the unce ations have been conduc on Equipment used (M&T Standards Multimeter Type 2001 ry Standards	rtainties with confidence pro- sted in the closed laboratory "E critical for calibration) ID # SN: 0810278	bability are given on the following pages facility: environment temperature (22 ± 3 <u>Cal Date (Certificate No.)</u> 15-Aug-20 (No:21092) Check Date (in house)	and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration Aug-21 Scheduled Check
The mea All calibra Calibratic <u>Primary S</u> Keithley I <u>Seconda</u> Auto DAE	surements and the unce ations have been conduc on Equipment used (M&T Standards Multimeter Type 2001	rtainties with confidence pro- sted in the closed laboratory "E critical for calibration) ID # SN: 0810278 ID # SE UWS 053 AA 1001	bability are given on the following pages facility: environment temperature (22 ± 3 <u>Cal Date (Certificate No.)</u> 15-Aug-20 (No:21092) Check Date (in house)	and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration Aug-21
The mea All calibra Calibratic Primary S Keithley ! Seconda Auto DAE Calibrato	surements and the unce ations have been conduc on Equipment used (M&T Standards Multimeter Type 2001 ny Standards E Calibration Unit r Box V2.1	rtainties with confidence pro- sted in the closed laboratory rE critical for calibration) ID # SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002	Deterministic procession Cal Date (Certificate No.) 15-Aug-20 (No:21092) Check Date (in house) 05-Jan-20 (in house check) 05-Jan-20 (in house check) D5-Jan-20 (in house check)	and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration Aug-21 Scheduled Check In house check: Jan-21
The mea All calibra Calibratic Primary S Keithley ! Seconda Auto DAE Calibrato	surements and the unce ations have been conduc on Equipment used (M&T Standards Multimeter Type 2001 ny Standards E Calibration Unit r Box V2.1	rtainties with confidence pro- sted in the closed laboratory (E critical for calibration) ID # SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002	Debability are given on the following pages r facility: environment temperature (22 ± 3 Cal Date (Certificate No.) 15-Aug-20 (No:21092) Check Date (in house) 05-Jan-20 (in house check) 05-Jan-20 (in house check)	and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration Aug-21 Scheduled Check In house check: Jan-21 In house check: Jan-21 Signature
The mea All calibra Calibratic <u>Primary S</u> Keithley I <u>Seconda</u> Auto DAE	surements and the unce ations have been conduc on Equipment used (M&T Standards Multimeter Type 2001 ny Standards E Calibration Unit r Box V2.1	rtainties with confidence pro- sted in the closed laboratory rE critical for calibration) ID # SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002	Deterministic procession Cal Date (Certificate No.) 15-Aug-20 (No:21092) Check Date (in house) 05-Jan-20 (in house check) 05-Jan-20 (in house check) D5-Jan-20 (in house check)	and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration Aug-21 Scheduled Check In house check: Jan-21 In house check: Jan-21 Signature
The mea All calibra Calibratic <u>Primary S</u> Keithley I <u>Seconda</u> Auto DAE Calibrato	surements and the unce ations have been conduc on Equipment used (M&T Standards Multimeter Type 2001 ry Standards E Calibration Unit r Box V2.1	rtainties with confidence pro- ted in the closed laboratory FE critical for calibration) ID # SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002 Name Dominique Steffen Sven Kühn	Cal Date (Certificate No.) 15-Aug-20 (No:21092) Check Date (in house) 05-Jan-20 (in house check) 05-Jan-20 (in house check) Laboratory Technician	and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration Aug-21 Scheduled Check In house check: Jan-21 In house check: Jan-21 Signature Signature IN BALL IN BALL ISSued: September 06, 20

Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Email:service@anbotek.com Tel:(86)755-26066440 Fax:(86)755-26014772

Aupo S A



Page 49 of 60

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates





S

C

S

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Glossary

DAE Connector angle data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a
 result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement. Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-387_Sep10

A

Page 2 of 5

Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com

DC Voltage Measurement

A/D - Converter Resolution nominal

Calibration Factors	х	Y	z
High Range	404.489 ± 0.02% (k=2)	404.852 ± 0.02% (k=2)	404.862 ± 0.02% (k=2)
Low Range	3.97827 ± 1.50% (k=2)	3.95875 ± 1.50% (k=2)	3.97982 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	53.0 ° ± 1 °

Certificate No: DAE4-387_Sep10

S

Page 3 of 5

Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com



Page 51 of 60

Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Inp	ut 200032.85	-3.31	-0.00
Channel X + Inp	ut 20007.64	1.88	0.01
Channel X - Inpu	it -20003.48	1.18	-0.01
Channel Y + Inp	ut 200034.23	-1.43	-0.00
Channel Y + Inp	ut 20006.60	0.91	0.00
Channel Y - Inpu	t -20004.04	0.72	-0.00
Channel Z + Inp	ut 200035.38	-0.83	-0.00
Channel Z + Inp	ut 20003.69	-2.11	-0.01
Channel Z - Inpu	t -20006.38	-1.59	0.01

Low Range	Reading (µV)	Difference (µV)	Error (%)	
Channel X + Input	2001.63	0.08	0.00	
Channel X + Input	202.29	0.70	0.35	
Channel X - Input	-197.90	0.60	-0.30	
Channel Y + Input	2001.33	-0.07	-0.00	
Channel Y + Input	200.86	-0.60	-0.30	
Channel Y - Input	-199.87	-1.23	0.62	
Channel Z + Input	2001.61	0.27	0.01	
Channel Z + Input	200.60	-0.70	-0.35	
Channel Z - Input	-199.51	-0.85	0.43	

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (µV)
Channel X	200	13.50	11.56
	- 200	-8.64	-11.18
Channel Y	200	-0.81	-1.28
	- 200	1.05	0.09
Channel Z	200	7.17	6.91
	- 200	-9.46	-9.01

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	-1.70	0.33
Channel Y	200	10.70		-0.38
Channel Z	200	7.11	7.89	-

Certificate No: DAE4-387_Sep10

S

Page 4 of 5

Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com



Page 52 of 60

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15969	17466
Channel Y	15661	16162
Channel Z	15990	16190

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input $10M\Omega$

	Average (µV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.73	-2.58	3.29	0.62
Channel Y	0.41	-0.49	1.23	0.40
Channel Z	-0.80	-1.88	0.30	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

S

Page 5 of 5

Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com



53 of 60 'age



Certificate No:

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: cttl@chinattl.com Http://www.chinattl.cn Anbotek (Auden)



Z18-97091

CALIBRATION CERTIFICATE

Object

D2450V2 - SN: 910

Calibration Procedure(s)

FD-Z11-2-003-01 Calibration Procedures for dipole validation kits

Calibration date:

Client

Jun 15, 2018

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	101919	01-Jul-17 (CTTL, No.J17X04256)	Jun-18
Power sensor NRP-Z91	101547	01-Jul-17 (CTTL, No.J17X04256)	Jun-18
Reference Probe EX3DV4	SN 7307	19-Feb-18(SPEAG,No.EX3-7307_Feb18)	Feb-19
DAE4	SN 771	02-Feb-18(CTTL-SPEAG,No.Z18-97011)	Feb-19
Secondary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Signal Generator E4438C	MY49071430	01-Feb-18 (CTTL, No.J18X00893)	Jan-19
Network Analyzer E5071C	MY46110673	26-Jan-18 (CTTL, No.J18X00894)	Jan-19

	Name	Function	Signature
Calibrated by:	Zhao Jing	SAR Test Engineer	At -
Reviewed by:	Qi Dianyuan	SAR Project Leader	too
Approved by:	Lu Bingsong	Deputy Director of the laboratory	- In usita
		Issued: Jun 17	
This calibration certif	icate shall not be reprodu	ced except in full without written approval of	the laboratory.

Certificate No: Z18-97091

Page 1 of 8

Shenzhen Anbotek Compliance Laboratory Limited



Anbotek 安博检测 Product Safety **Anbotek Testing**

Report No.: 18220WC00157401



Tel: +86-10-62304633-2079 E-mail: cttl@chinattl.com

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Fax: +86-10-62304633-2504 Http://www.chinattl.cn

Glossary:

TSL ConvF N/A

tissue simulating liquid sensitivity in TSL / NORMx,y,z not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to measure the Specific Absorption Rate (SAR) For wireless communication devices used in close proximity to the human body (frequency range of 30MHz to 6GHz)", March 2010
- d) KDB865664, SAR Measurement Requirements for 100 MHz to 6 GHz

Additional Documentation:

e) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

Certificate No: Z18-97091

Page 2 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com



Page 54 of 60

Anbotek Product Safety

Report No.: 18220WC00157401



In Collaboration with
SDEAD

 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: cttl@chinattl.com
 Http://www.chinattl.cn

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY52	52.8.8.1258
Extrapolation	Advanced Extrapolation	
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.0 ± 6 %	1.77 mho/m ± 6 %
Head TSL temperature change during test	<1.0 °C		

SAR result with Head TSL

SAR averaged over 1 cm^3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	52.4 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm^3 (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	6.06 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.3 mW /g ± 20.4 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	52.7	1.95 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.9 ± 6 %	1.97 mho/m ± 6 %
Body TSL temperature change during test	<1.0 °C		

SAR result with Body TSL

SAR averaged over 1 cm^3 (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	51.8 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	6.18 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	24.7 mW /g ± 20.4 % (k=2)

Certificate No: Z18-97091

Page 3 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com Hotline 400-003-0500 www.anbotek.com



Page 56 of 60



CALIBRATION LABORATORY

 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: ettl@chinattl.com
 Http://www.chinattl.cn

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	54.6Ω+ 2.77jΩ
Return Loss	- 25.8dB

а

Antenna Parameters with Body TSL

Impedance, transformed to feed point	50.7Ω+ 4.28jΩ	
Return Loss	- 27.3dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.263 ns	

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------

Certificate No: Z18-97091

Page 4 of 8

Shenzhen Anbotek Compliance Laboratory Limited



Anbotek Product Safety

Report No.: 18220WC00157401

Page 57 of 60



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: cttl@chinattl.com
 Http://www.chinattl.cn

Date: 06.15.2018

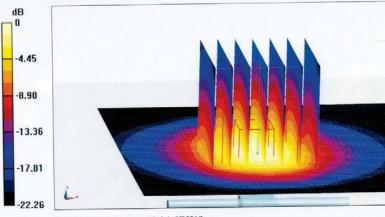
DASY5 Validation Report for Head TSLDate: 06.15Test Laboratory: CTTL, Beijing, ChinaDut: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910Our: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1Medium parameters used: f = 2450 MHz; $\sigma = 1.767$ S/m; cr = 39.01; $\rho = 1000$ kg/m3Phantom section: Right SectionMeasurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.36, 7.36, 7.36); Calibrated: 2/19/2018;
- · Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2018-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 106.5 V/m; Power Drift = 0.02 dB

Reference Value = 106.5 V/m; Power Diff = 0.02 d Peak SAR (extrapolated) = 26.7 W/kg SAR(1 g) = 13 W/kg; SAR(10 g) = 6.06 W/kg Maximum value of SAR (measured) = 19.7 W/kg



0 dB = 19.7 W/kg = 12.94 dBW/kg

Certificate No: Z18-97091

Page 5 of 8

Shenzhen Anbotek Compliance Laboratory Limited





Page 58 of 60

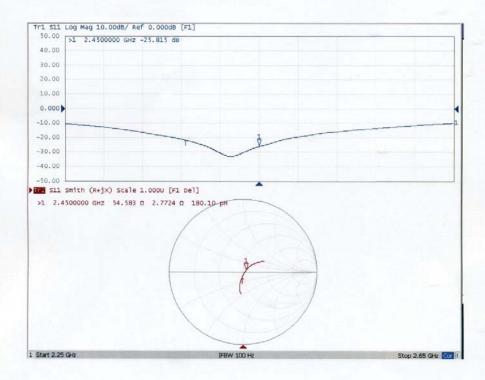


 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: cttl@chinattl.com
 Http://www.chinattl.cn

Impedance Measurement Plot for Head TSL



Certificate No: Z18-97091

Page 6 of 8

Shenzhen Anbotek Compliance Laboratory Limited



安博检测 Anbotek **Product Safety** Anbotek Testing

Report No.: 18220WC00157401

Page 59 of 60



e а CALIBRATION LABORATORY

Tel: +86-10-62304633-2079 E-mail: cttl@chinattl.com

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Fax: +86-10-62304633-2504 Http://www.chinattl.cn

DASY5 Validation Report for Body TSL Test Laboratory: CTTL, Beijing, China

Date: 06.15.2018

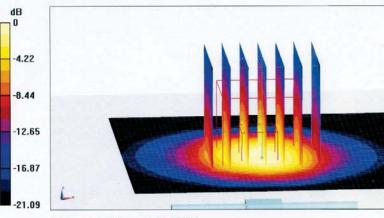
DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910 Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; $\sigma = 1.972 \text{ S/m}$; $\epsilon_r = 52.92$; $\rho = 1000 \text{ kg/m}^3$ Phantom section: Center Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.22, 7.22, 7.22); Calibrated: 2/19/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2018-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372) .

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 98.89 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 25.6 W/kg SAR(1 g) = 13 W/kg; SAR(10 g) = 6.18 W/kg Maximum value of SAR (measured) = 19.3 W/kg



0 dB = 19.3 W/kg = 12.86 dBW/kg

Certificate No: Z18-97091

Page 7 of 8

Shenzhen Anbotek Compliance Laboratory Limited

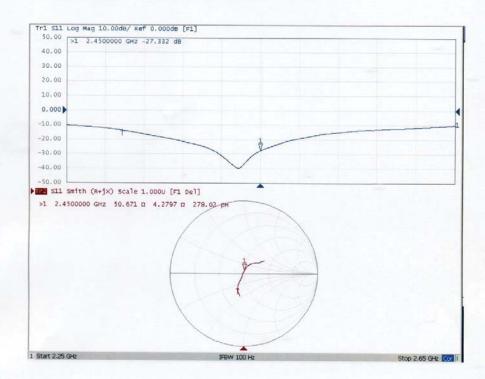




Page 60 of 60



Impedance Measurement Plot for Body TSL



Certificate No: Z18-97091

Page 8 of 8

END OF REPORT***** ****

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com

Hotline ß 400-003-0500 www.anbotek.com